## Poster Presentations

## [MS1-P02] Submicrosecond X-ray Crystallography: New Technique, Challenges and Opportunities

<u>Semen Gorfman</u><sup>a</sup>, Michael Ziolkowski<sup>a</sup>, Manuel Angst<sup>b</sup>, Shilpa Adiga<sup>b</sup>, Hyeokmin Choe<sup>a</sup>, Mohammad al Taani<sup>a</sup>, Ullrich Pietsch<sup>a</sup>,

<sup>a</sup>University of Siegen, Siegen, bFZ Juelich, Juelich, Germany. E-mail: gorfman@physik.uni-siegen.de

Investigation of structural dynamics of crystals under external perturbation is one of the major challenges for modern X-ray structure analysis. This interest is motivated by both fundamental and material sciences, since sensitivity of a structure to a perturbation predefines numerous macroscopic physical properties. In this work we show recent achievments using a new dataaquisition system (DAQ) for a broad range of time-resolved diffraction experiment with a point detector [1]. It applies to probe the reversible submicro-, micro- or millisecond periodically dvnamics under modulated external electric field such as a) dynamics of domains in ferroelectrics and multiferroic; b) piezoelectrically induced elastic vibrations; c) dynamics of field induced phase transitions, etc. The DAQ is constructed on the basis of a Field Programmable Gate Array (FPGA-board), which distributes the point detector signals in 10000 time channels, synchronized with an applied electric perturbation. It allows for a flexible change of the channel width (> 100 ns), i.e. the time resolution of the experiment.



[1] Gorfman, S., Schmidt, O., Ziolkowski, M., Kozierowski, M., & Pietsch, U. (2010). J. Appl. Phys. 108, 064911.

**Keywords:** time-resolved X-ray diffraction; Piezoelectricity; Ferroelectricity

